

Exams for group M16-406

Fri, 22 Dec	10:15 — 11:50	ATT	Elect	Electronic Systems Design	🎓 Alyushin M.V. 📍 K-1006
Fri, 22 Dec	10:15 — 11:50	ATT	Elect	Modern Micro and Nanotechnologies	🎓 Veselov D.S. 📍 D-303
Fri, 22 Dec	12:00 — 15:00	TEST		Legal and International Aspects of Nonproliferation and Nuclear Materials Safety.	🎓 Kulikov E.G. 📍 403
Fri, 22 Dec	15:00 — 18:00	TEST		Principles of Nuclear Technologies	🎓 Apse V.A. 📍 403
Mon, 25 Dec	09:00 — 12:00	ATT	Elect	Principles of Nuclear Electronics	🎓 Garmash A.A., Atkin E.V. 📍 V-306
Mon, 25 Dec	09:00 — 12:00	ATT	Elect	Design of Integrated Circuits and Systems-on-Chip (SOC)	🎓 Bakerenkov A.S. 📍 D-408
Mon, 25 Dec	12:45 — 14:20	ATT	Elect	Reliability and Radiation Resistance of Microelectronic Devices and Systems	🎓 Zebrev G.I. 📍 D-408
Mon, 25 Dec	12:45 — 14:20	ATT	Elect	Elements of Fault-tolerant Devices	🎓 Skorobogatov P.K. 📍 V-306
Mon, 25 Dec	15:00 — 18:00	TEST		Computer Technology	🎓 Krasavin A.V. 📍 V-117
Thu, 28 Dec	08:30 — 10:05	TEST		Law and Economics of Scientific Projects and Units	🎓 Nurahov N.N. 📍 K-210
Thu, 28 Dec	12:00 — 15:00	TEST		Practical Training (Research Work)	🎓 Samotaev N.N. 📍 dep.27
Tue, 09 Jan	09:00 — 13:00	EXAM	Elect	Reliability and Radiation Resistance of Microelectronic Devices and Systems	🎓 Zebrev G.I. 📍 D-408
Tue, 09 Jan	09:00 — 13:00	EXAM	Elect	Elements of Fault-tolerant Devices	🎓 Skorobogatov P.K. 📍 V-306
Mon, 15 Jan	09:00 — 13:00	EXAM	Elect	Electronic Systems Design	🎓 Alyushin M.V. 📍 K-1006
Mon, 15 Jan	09:00 — 13:00	EXAM	Elect	Modern Micro and Nanotechnologies	🎓 Veselov D.S. 📍 D-303
Mon, 22 Jan	09:00 — 13:00	EXAM	Elect	Principles of Nuclear Electronics	🎓 Garmash A.A., Atkin E.V. 📍 V-306
Mon, 22 Jan	09:00 — 13:00	EXAM	Elect	Design of Integrated Circuits and Systems-on-Chip (SOC)	🎓 Bakerenkov A.S. 📍 D-408